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ON Semiconductor®

FDD8880

N-Channel PowerTrench[®] MOSFET 30V, 58A, 9m Ω

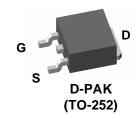
General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{\text{DS}(\text{ON})}$ and fast switching speed.

Applications



DC/DC converters



Features

- $r_{DS(ON)} = 9m\Omega$, $V_{GS} = 10V$, $I_D = 35A$
- $r_{DS(ON)} = 12m\Omega, V_{GS} = 4.5V, I_D = 35A$
- High performance trench technology for extremely low ${\rm r}_{\rm DS(ON)}$
- Low gate charge
- High power and current handling capability
- RoHS Compliant



MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol		Parameter		Ratings	Units
V _{DSS}	Drain to Source Voltage		30	V	
V _{GS}	Gate to Source Voltage			±20	V
ID	Drain Current				
	Continuous ($T_C = 25^{\circ}C$,	58	A		
	Continuous ($T_C = 25^{\circ}C$,	51	А		
	Continuous (T _{amb} = 25°C	13	A		
	Pulsed	Figure 4	A		
E _{AS}	Single Pulse Avalanche	Energy (Note 2)		53	mJ
P _D	Power dissipation			55	W
	Derate above 25°C	0.37	W/ºC		
T _J , T _{STG}	Operating and Storage	emperature		-55 to 175	°C
Therma	I Characteristics				
$R_{\theta JC}$	Thermal Resistance Jun	ction to Case TO-252		2.73	°C/W
R _{θJC} R _{θJA}		ction to Case TO-252 ction to Ambient TO-252		2.73 100	
	Thermal Resistance Jun		copper pad area	-	°C/W °C/W °C/W
R _{θJA} R _{θJA}	Thermal Resistance Jun Thermal Resistance Jun	ction to Ambient TO-252		100	°C/W

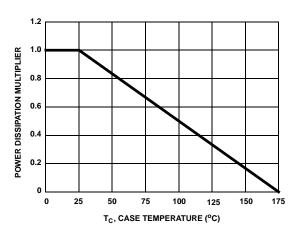
Publication Order Number: FDD8880/D

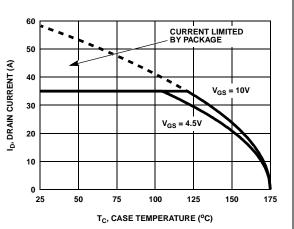
2500 units

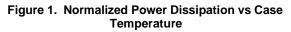
Symbol	Parameter	Test Condi	Min	Тур	Max	Units	
Off Chara	acteristics						
B _{VDSS}	Drain to Source Breakdown Voltage	I _D = 250μA, V _{GS} = 0V		30	-	-	V
I _{DSS}	Zana Cata Maltana Dusia Cumant	V _{DS} = 24V	-	-	1		
	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ T	_C = 150 ^o C	-	-	250	μA
GSS	Gate to Source Leakage Current	$V_{GS} = \pm 20V$		-	-	±100	nA
On Chara	acteristics						
/ _{GS(TH)}	Gate to Source Threshold Voltage $V_{GS} = V_{DS}$, $I_D = 250 \mu A$		ί0μΑ	1.2	-	2.5	V
00(11)		I _D = 35A, V _{GS} = 10V		-	0.007	0.009	Ω
	Drain to Source On Resistance	$I_D = 35A, V_{GS} = 4.5$	-	0.009	0.012		
DS(ON)	Diam to Source On Resistance	$I_D = 35A, V_{GS} = 10$ $T_J = 175^{o}C$	-	0.013	0.015		
vnamic	Characteristics						
riss	Input Capacitance			-	1260	-	pF
Poss	Output Capacitance	$V_{DS} = 15V, V_{GS} = 0V,$ f = 1MHz		-	260	-	, pF
RSS	Reverse Transfer Capacitance			-	150	-	pF
G	Gate Resistance	V _{GS} = 0.5V, f = 1MHz		-	2.3	-	Ω
g(TOT)	Total Gate Charge at 10V	$V_{GS} = 0V \text{ to } 10V$		-	23	31	nC
g(5)	Total Gate Charge at 5V	$V_{CS} = 0V$ to 5V		-	13	17	nC
g(U) g(TH)	Threshold Gate Charge	$V_{cc} = 0V \text{ to } 1V$	/ _{DD} = 15V	-	1.3	1.7	nC
gs	Gate to Source Gate Charge	$I_{g} = 35A$ $I_{g} = 1.0mA$		-	3.8	-	nC
gs2	Gate Charge Threshold to Plateau			-	2.5	-	nC
gd	Gate to Drain "Miller" Charge			-	5.0	-	nC
witching	g Characteristics (V _{GS} = 10V)						
DN .	Turn-On Time			-	-	147	ns
(ON)	Turn-On Delay Time	$V_{DD} = 15V, I_D = 35A$ $V_{GS} = 10V, R_{GS} = 10\Omega$		-	8	-	ns
	Rise Time			-	91	-	ns
(OFF)	Turn-Off Delay Time			-	38	-	ns
(011)	Fall Time			-	32	-	ns
)FF	Turn-Off Time			-	-	108	ns
rain-So	urce Diode Characteristics	·					
		I _{SD} = 35A		-	-	1.25	V
V _{SD}	Source to Drain Diode Voltage	I _{SD} = 15A	-	-	1.0	V	
	Reverse Recovery Time	$I_{SD} = 35A$, $dI_{SD}/dt = 100A/\mu s$		-	-	27	ns
r	Reverse Recovered Charge	I _{SD} = 35A, dI _{SD} /dt = 100A/µs		-	-	14	nC



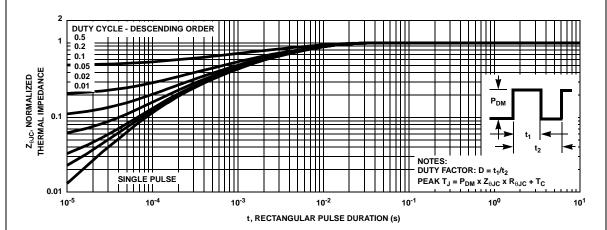
Typical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

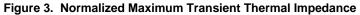


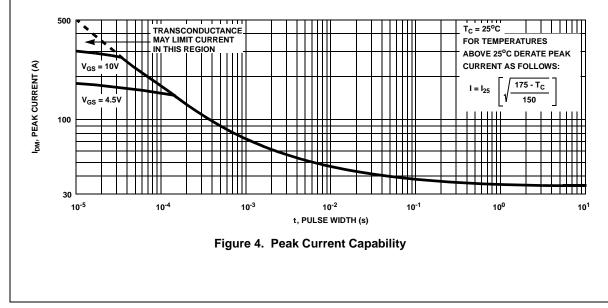




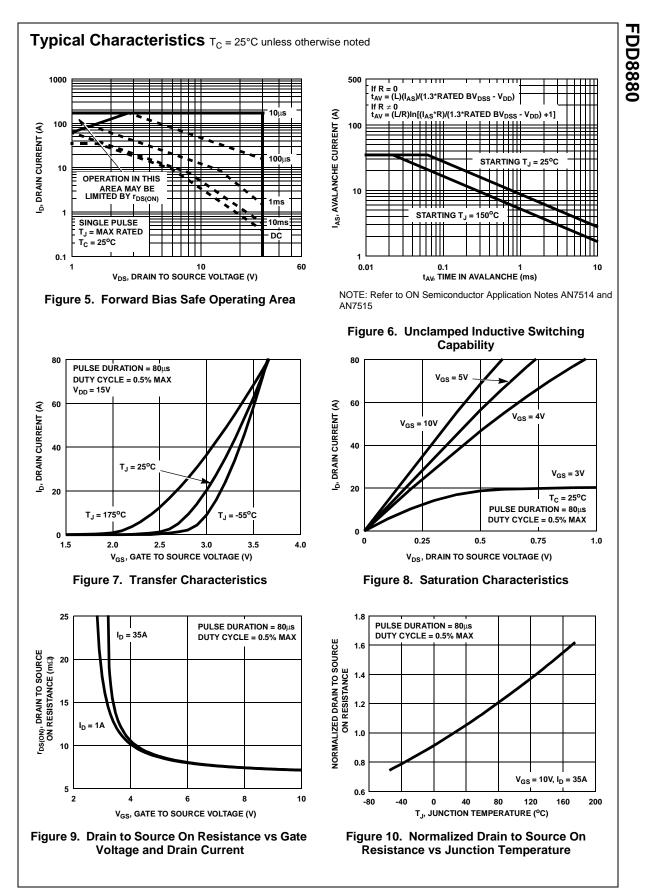


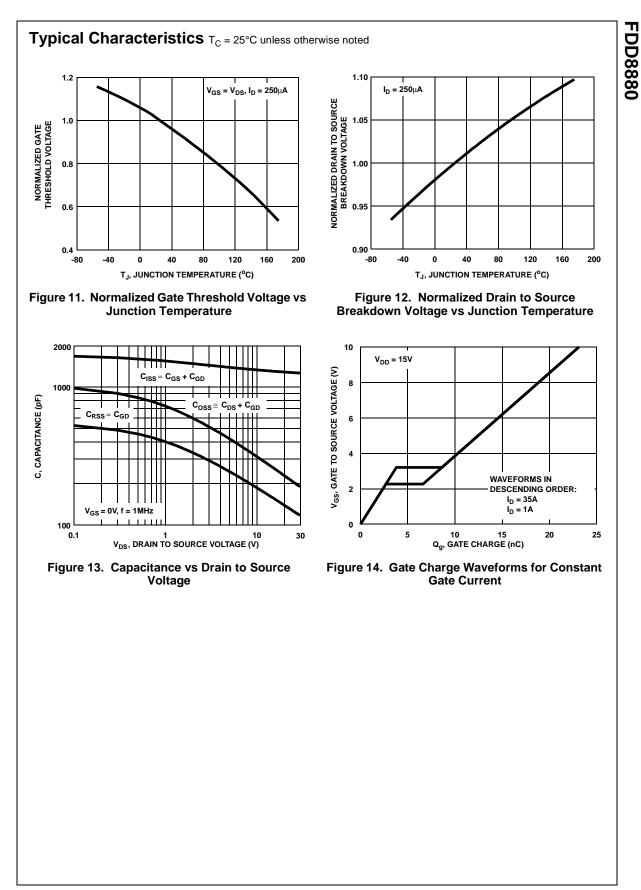




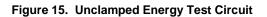


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Test Circuits and Waveforms



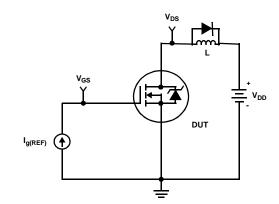


Figure 17. Gate Charge Test Circuit

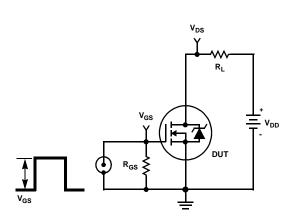
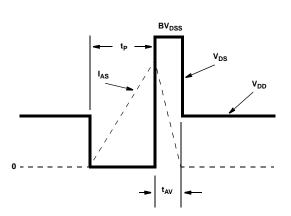
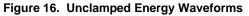


Figure 19. Switching Time Test Circuit





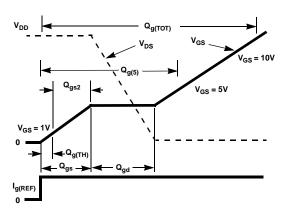


Figure 18. Gate Charge Waveforms

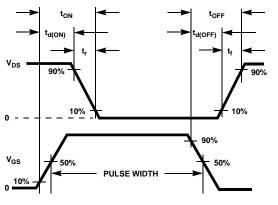


Figure 20. Switching Time Waveforms

Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature, T_{JM} , and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation, P_{DM} , in an application. Therefore the application's ambient temperature, T_A (°C), and thermal resistance $R_{\theta JA}$ (°C/W) must be reviewed to ensure that T_{JM} is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}}$$
(EQ. 1)

In using surface mount devices such as the TO-252 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of P_{DM} is complex and influenced by many factors:

- Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
- 2. The number of copper layers and the thickness of the board.
- 3. The use of external heat sinks.
- 4. The use of thermal vias.
- 5. Air flow and board orientation.
- 6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

ON Semiconductor provides thermal information to assist the designer's preliminary application evaluation. Figure 21 defines the $R_{\theta JA}$ for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the ON Semiconductor device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

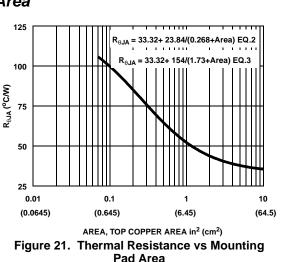
Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2 or 3. Equation 2 is used for copper area defined in inches square and equation 3 is for area in centimeters square. The area, in square inches or square centimeters is the top copper area including the gate and source pads.

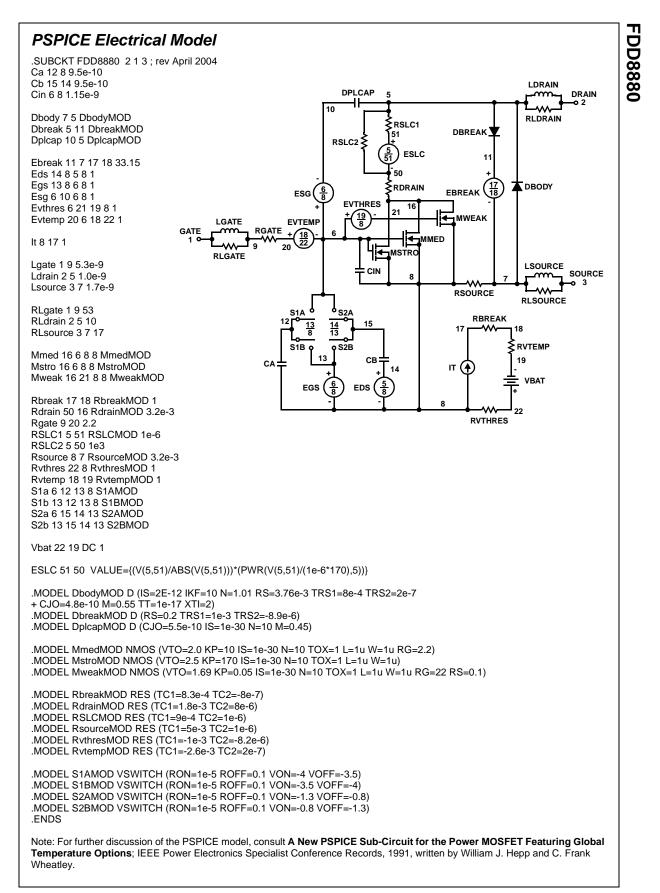
$$R_{\theta JA} = 33.32 + \frac{23.84}{(0.268 + Area)}$$
 (EQ. 2)

Area in Inches Squared

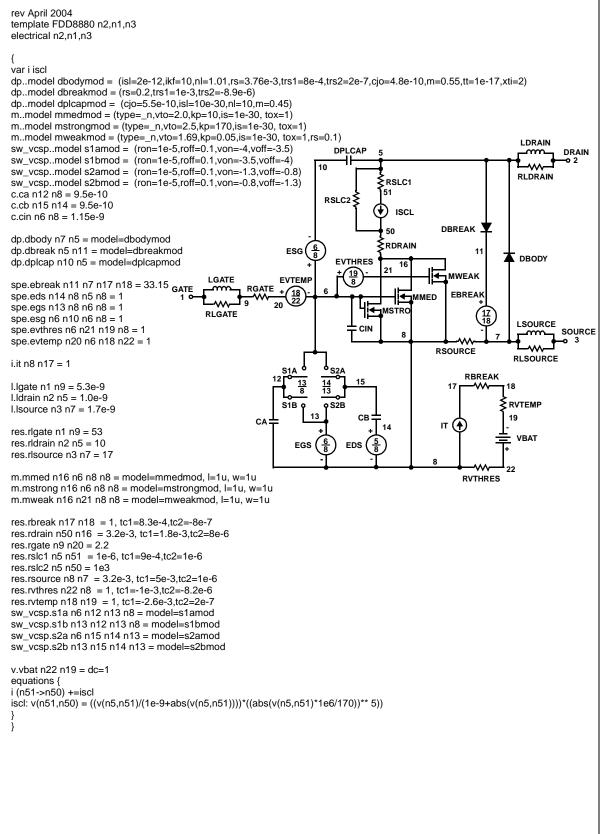
$$R_{\theta JA} = 33.32 + \frac{154}{(1.73 + Area)}$$
(EQ. 3)

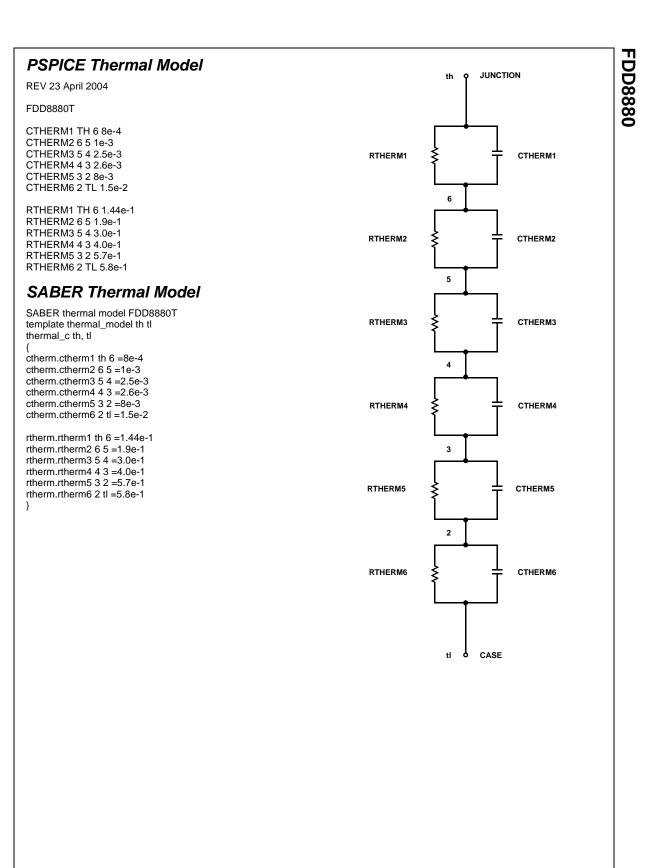
Area in Centimeters Squared





SABER Electrical Model





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